

<b>Notice of References Cited</b>	Application/Control No. 10/606,801	Applicant(s)/Patent Under Reexamination TSUJITA ET AL.	
	Examiner Tianjie Chen	Art Unit 2652	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0020484	02-2002	Feist et al.	156/196
	B	US-6,309,729 B1	10-2001	Glushko et al.	428/64.1
	C	US-6,280,811 B1	08-2001	Nee, Han H.	428/64.1
	D	US-5,876,823 A	03-1999	Nagashima, Michiyoshi	428/64.1
	E	US-5,702,792	12-1997	Iida et al.	428/64.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10143924 A	05-1998	Japan	KOBAYASHI, MASAKAZU	-----
	O	<i>(With Translation)</i>				
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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